MSKSEMI 美森科













ESD

T\/

TSS

MOV

GDI

PLED

2N7002

Product specification





Features

- 60V,0.3A, RDS(ON) =2.2Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

Application

- Motor Drive
- Power Tools
- LED Lighting

BVDSS	RDSON	ID
60V	2.2Ω	0.3A

Reference News

PACKAGE OUTLINE	Pin Configuration	Marking
G S SOT-23	G	7002

Absolute Maximum Ratings (TA=25 $^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain- Source Voltage	60	V
Vgs	Gate- Sou₁ce Voltage	±20	V
ID	Drain Current – Continuous (T _C =25°c)	0.3	А
	Drain Current – Continuous (T _C =100 °c)	0.1	Α
Ідм	Drain Current – Pulsed¹	0.8	Α
Pp	Power Dissipation (T _C =25 ℃)	0.35	W
	Power Dissipation – Derate above 25 ℃	0.003	W / ℃
Тѕтс	Storage Temperature Range	-50 to 150	°C
Tu	Operating Junction Temperature Range	-50 to 150	°C



Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		357	∘c/W

Electrical Characteristics(TJ=25 °C , unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain- Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60		-	V
1	Drain- Source Leakage Current	V _{DS} =60V , V _{GS} =0V , T _J =25℃			1	ŭΑ
IDSS		V _{DS} =48V , V _{GS} =0V , T _J =125℃			10	uА
lgss	Gate- Source Leakage Current	V _{GS} ±20V , V _{DS} =0V			±10	uА

On Characteristics

Б	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =0.3A		2.2	2.8	Ω
Rds(on)	Static Drain-Source On-Nesistance	V _{GS} =4.5V , I _D =0.2A		2 4	3 0	Ω
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1	1.6	2.5	V
gfs	Forward Transconductance	V _{DS} =10V , I _D =0.3A		0.5		S

Dynamic and switching Characteristics

,					
Q_g	Total Gate Charge ^{2, 3}		 3.7	5.6	
Q_{gs}	Gate-Source Charge ^{2, 3}	V_{DS} =30V , V_{GS} =10V , I_{D} =1A	 0.9	1.4	nC
Q_{gd}	Gate-Drain Charge ^{2, 3}		 0.4	0.6	
T _{d(on)}	Turn-On Delay Time ^{2, 3}		 3	6	
Tr	Rise Time ^{2, 3}	V_{DD} =30V , V_{GS} =10V , R_G =6 Ω	 5	10	ns
T _{d(off)}	Turn-Off Delay Time ^{2, 3}	I _D =0.2A	 14	27	115
Tf	Fall Time ^{2, 3}		 9	17	
Ciss	Input Capacitance		 25.5	38	
Coss	Output Capacitance	V_{DS} =30V , V_{GS} =0V , F=1MHz	 17	26	pF
Crss	Reverse Transfer Capacitance		 7.8	12	•

Drain-Source Diode Characteristics and Maximum Ratings

	g					
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			0.3	Α
lsм	Pulsed Source Current	VG-VD-0V, I OICE Cullent			1.2	Α
Vsp	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1	V
t rr	Reverse Recovery Time	V_{GS} =50V, I_{S} =1A , dI/dt =100A/ μs		3.4		ns
Qrr	Reverse Recovery Charge	T _J =25℃		0.7		nC

Note:

- 1.Repetitive Rating: Pulsed width limited by maximum junction temperature.
- $2\,.$ The data tested by pulsed , pulse width $\leqq 300\,us$, duty cycle $\leqq 2\,\%\,.$
- 3. Essentially independent of operating temperature.



ELECTRICAL CHARACTERISTICS CURVE

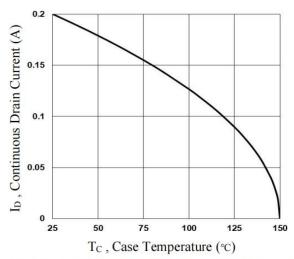


Fig.1 Continuous Drain Current vs. Tc

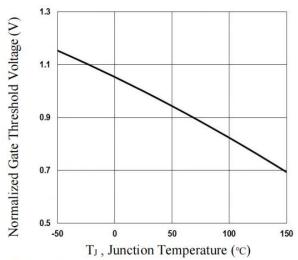


Fig.3 Normalized V_{th} vs. T_J

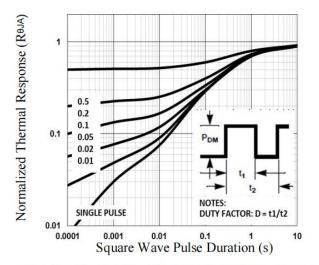


Fig.5 Normalized Transient Impedance

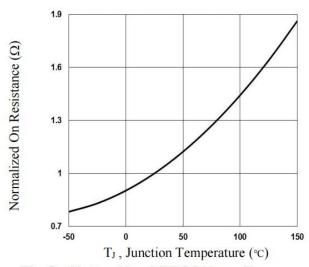


Fig.2 Normalized RDSON vs. TJ

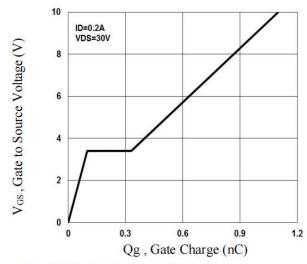


Fig.4 Gate Charge Waveform

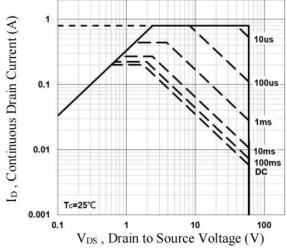
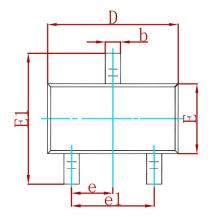
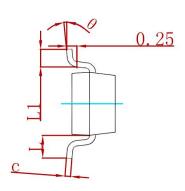


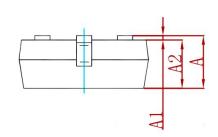
Fig.6 Maximum Safe Operation Area



PACKAGE MECHANICAL DATA

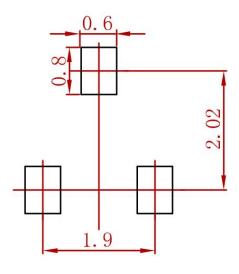






Symbol	Dimensions	Dimensions In Millimeters		s In Inches	
Syllibol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950) TYP	0.03	7 TYP	
e1	1.800	2.000	0.071	0.079	
L	0.550	REF	0.022 REF		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
2N7002	SOT-23	3000



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